**Product data sheet** 

## 1. General description

Planar passivated Silicon Controlled Rectifier in a SOT429N (TO247) plastic package intended for use in applications requiring very high inrush current capability and high thermal cycling performance.

### 2. Features and benefits

- · High thermal cycling performance
- · Planar passivated for voltage ruggedness and reliability
- · High voltage capacity
- · Very high current surge capability

# 3. Applications

- Line rectifying 50/60 Hz
- Softstart AC motor control
- DC Motor control
- Power converter
- · AC power control
- Lighting and temperature control
- Uninterruptible Power Supply (UPS)
- Solid State Relay (SSR)
- · Traction battery charging

### 4. Quick reference data

Table 1. Quick reference data

Symbol	Parameter	Conditions		Min	Тур	Max	Unit
$V_{RRM}$	repetitive peak reverse voltage			-	-	1200	V
I <sub>T(AV)</sub>	average on-state current	half sine wave; $T_{mb} \le 117 ^{\circ}C$		-	-	80	Α
I <sub>T(RMS)</sub>	RMS on-state current	half sine wave; $T_{mb} \le 117 ^{\circ}\text{C}$ ; Fig. 1; Fig. 2; Fig. 3		-	-	126	Α
I <sub>TSM</sub>	non-repetitive peak on- state current	half sine wave; $T_{j(init)}$ = 25 °C; $t_p$ = 10 ms; <u>Fig. 4</u> ; <u>Fig. 5</u>		-	-	1100	Α
		half sine wave; $T_{j(init)} = 25 ^{\circ}C$ ; $t_p = 8.3  \text{ms}$		-	-	1210	Α
T <sub>j</sub>	junction temperature			-	-	150	°C
Static characteristics							

Symbol	Parameter	Conditions	Min	Тур	Max	Unit
I <sub>GT</sub>	gate trigger current	$V_D = 12 \text{ V}; I_T = 0.1 \text{ A}; T_j = 25 \text{ °C}; Fig. 7; Fig. 8}$	-	-	70	mA
Dynamic chara	acteristics					
dV <sub>D</sub> /dt	rate of rise of off-state voltage	$V_{DM}$ = 800 V; $T_j$ = 125 °C; $R_{GK}$ = 100 $\Omega$ ; $(V_{DM}$ = 67% of $V_{DRM}$ ); exponential waveform	1500	-	-	V/µs
		$V_{DM}$ = 800 V; $T_j$ = 150 °C; $R_{GK}$ = 100 $\Omega$ ; $(V_{DM}$ = 67% of $V_{DRM}$ ); exponential waveform	1000	-	_	V/µs

# 5. Pinning information

#### **Table 2. Pinning information**

Pin	Symbol	Description	Simplified outline	Graphic symbol
1	K	cathode		A <del>- [&gt;] -</del> K
2	Α	anode		G sym037
3	G	gate		Symosi
mb	A	mounting base; connected to anode	1 2 3 TO-247 (SOT429N)	

# 6. Ordering information

#### **Table 3. Ordering information**

Type number	Package				
	Name	Description	Version		
BT158W-1200T	TO-247	Plastic single-ended through-hole package; heatsink mounted; 1 mounting hole; 3-lead TO-247	SOT429N		

# 7. Limiting values

#### **Table 4. Limiting values**

In accordance with the Absolute Maximum Rating System (IEC 60134).

Symbol	Parameter	Conditions	Min	Max	Unit
$V_{DRM}$	repetitive peak off-state voltage		-	1200	V
$V_{RRM}$	repetitive peak reverse voltage		-	1200	V
I <sub>T(AV)</sub>	average on-state current	half sine wave; T <sub>mb</sub> ≤ 117 °C	-	80	Α
I <sub>T(RMS)</sub>	RMS on-state current	half sine wave; $T_{mb} \le 117 ^{\circ}\text{C}$ ; Fig. 1; Fig. 2; Fig. 3	-	126	А
I <sub>TSM</sub>	non-repetitive peak on- state current	half sine wave; $T_{j(init)} = 25$ °C; $t_p = 10$ ms; Fig. 4; Fig. 5	-	1100	Α
		half sine wave; T <sub>j(init)</sub> = 25 °C; t <sub>p</sub> = 8.3 ms	-	1210	Α
l <sup>2</sup> t	I <sup>2</sup> t for fusing	t <sub>p</sub> = 10 ms; sine-wave pulse; T <sub>j(init)</sub> = 25 °C; no voltage reapplied	-	6115	A²s
dl <sub>T</sub> /dt	rate of rise of on-state current	I <sub>G</sub> = 200 mA	-	150	A/µs
I <sub>GM</sub>	peak gate current		-	8	Α
$V_{RGM}$	peak reverse gate voltage		-	5	V
$P_{GM}$	peak gate power		-	20	W
P <sub>G(AV)</sub>	average gate power	over any 20 ms period	-	1	W
T <sub>stg</sub>	storage temperature		-40	150	°C
T <sub>j</sub>	junction temperature		-	150	°C

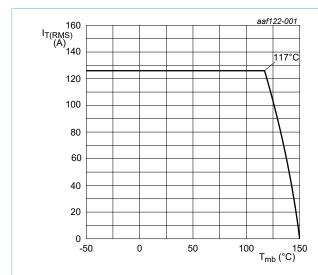


Fig. 1. RMS on-state current as a function of mounting base temperature; maximum values

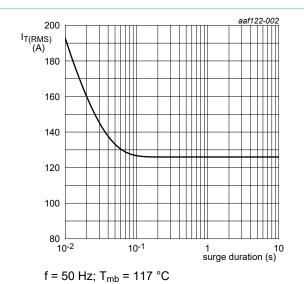


Fig. 2. RMS on-state current as a function of surge duration; maximum values

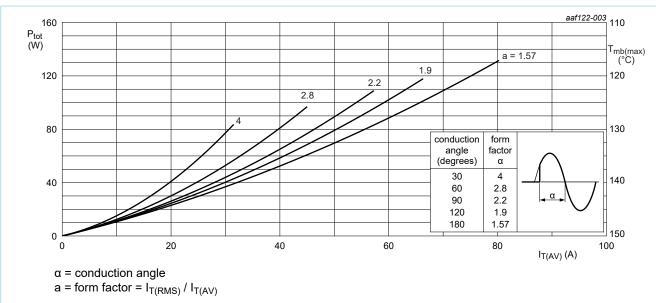


Fig. 3. Total power dissipation as a function of average on-state current; maximum values

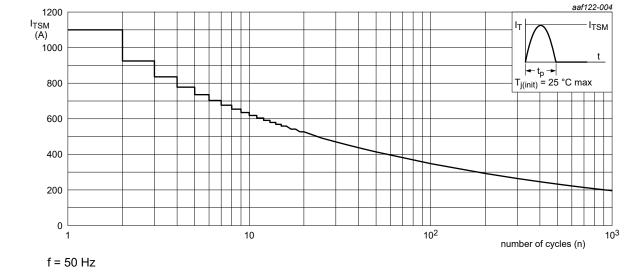
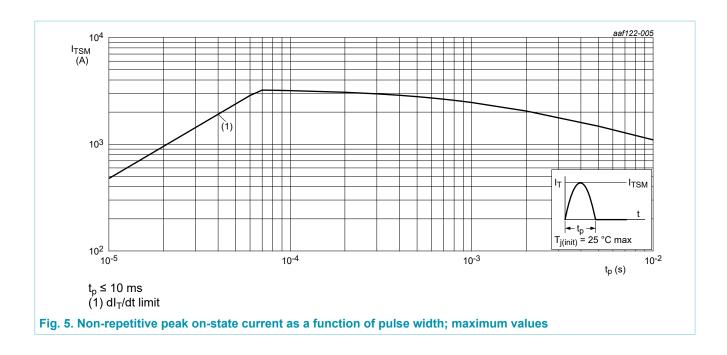


Fig. 4. Non-repetitive peak on-state current as a function of the number of sinusoidal current cycles; maximum values



### 8. Thermal characteristics

**Table 5. Thermal characteristics** 

Symbol	Parameter	Conditions	Min	Тур	Max	Unit
R <sub>th(j-mb)</sub>	thermal resistance from junction to mounting base	full cycle; Fig. 6	-	-	0.25	K/W
R <sub>th(j-a)</sub>	thermal resistance from junction to ambient free air	in free air	-	50	-	K/W

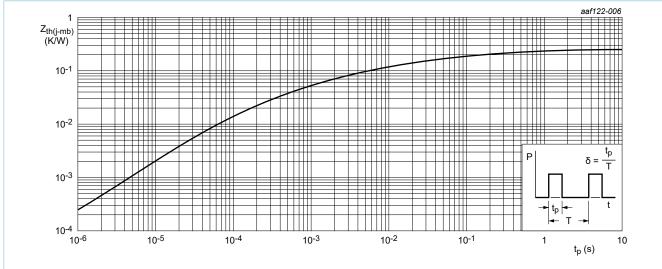


Fig. 6. Transient thermal impedance from junction to mounting base as a function of pulse duration

## 9. Characteristics

#### Table 6. Characteristics

Symbol	Parameter	Conditions	Min	Тур	Max	Unit
Static chara	acteristics		,			
I <sub>GT</sub>	gate trigger current	$V_D = 12 \text{ V}; I_T = 0.1 \text{ A}; T_j = 25 \text{ °C}; Fig. 7; Fig. 8}$	-	-	70	mA
IL	latching current	V <sub>D</sub> = 12 V; I <sub>G</sub> = 0.1 A; T <sub>j</sub> = 25 °C; <u>Fig. 9</u>	-	-	300	mA
I <sub>H</sub>	holding current	V <sub>D</sub> = 12 V; T <sub>j</sub> = 25 °C; <u>Fig. 10</u>	-	-	200	mA
V <sub>T</sub>	on-state voltage	I <sub>T</sub> = 80 A; T <sub>j</sub> = 25 °C; <u>Fig. 11</u>	-	-	1.35	V
		I <sub>T</sub> = 160 A; T <sub>j</sub> = 25 °C; <u>Fig. 11</u>	-	-	1.65	V
$V_{GT}$	gate trigger voltage	$V_D = 12 \text{ V}; I_T = 0.1 \text{ A}; T_j = 25 \text{ °C};$ Fig. 12	-	0.7	1	V
		$V_D = 800 \text{ V}; I_T = 0.1 \text{ A}; T_j = 125 ^{\circ}\text{C};$ Fig. 12	0.25	0.4	-	V
I <sub>D</sub>	off-state current	V <sub>D</sub> = 1200 V; T <sub>j</sub> = 125 °C	-	-	3	mA
I <sub>R</sub>	reverse current	V <sub>R</sub> = 1200 V; T <sub>j</sub> = 125 °C	-	-	3	mA
Dynamic ch	naracteristics				'	
dV <sub>D</sub> /dt	rate of rise of off-state voltage	$V_{DM}$ = 800 V; $T_j$ = 125 °C; $R_{GK}$ = 100 $\Omega$ ; $(V_{DM}$ = 67% of $V_{DRM}$ ); exponential waveform	1500	-	-	V/µs
		$V_{DM}$ = 800 V; $T_j$ = 150 °C; $R_{GK}$ = 100 $\Omega$ ; $(V_{DM}$ = 67% of $V_{DRM}$ ); exponential waveform	1000	-	-	V/µs
t <sub>gt</sub>	gate-controlled turn-on time	$I_{TM}$ = 40 A; $V_D$ = 800 V; $I_G$ = 0.1 A; $dI_G/$ dt = 5 A/µs; $T_j$ = 25 °C	-	2	-	μs
t <sub>q</sub>	commutated turn-off time	$V_{DM} = 804 \text{ V}; T_j = 125 \text{ °C}; I_{TM} = 20 \text{ A}; V_R = 25 \text{ V}; (dI_T/dt)_M = 30 \text{ A/}\mu\text{s}; dV_D/dt = 50 \text{ V/}\mu\text{s}; R_{GK(ext)} = 100 \text{ k}\Omega; (V_{DM} = 67\% \text{ of } V_{DRM})$	-	150	-	μs
Mounting c	haracteristics					
t <sub>gt</sub>	gate-controlled turn-on time	I <sub>TM</sub> = 2 A	-	2	-	μs
t <sub>q</sub>	commutated turn-off time	I <sub>TM</sub> = 20 A	-	150	-	μs

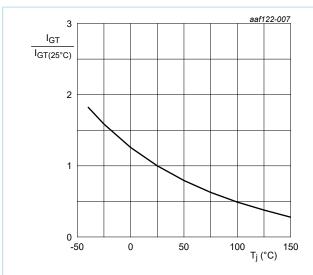


Fig. 7. Normalized gate trigger current as a function of junction temperature

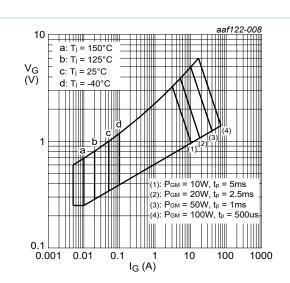


Fig. 8. Gate voltage as a function of gate current

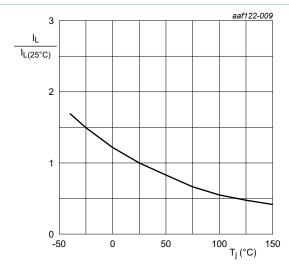


Fig. 9. Normalized latching current as a function of junction temperature

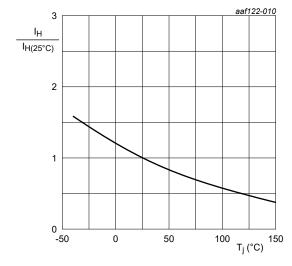
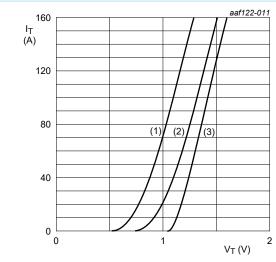


Fig. 10. Normalized holding current as a function of junction temperature

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 $V_o$  = 0.984 V;  $R_s$  = 0.0033 Ω (1)  $T_j$  = 150 °C; typical values (2)  $T_j$  = 150 °C; maximum values (3)  $T_j$  = 25 °C; maximum values

Fig. 11. On-state current as a function of on-state voltage

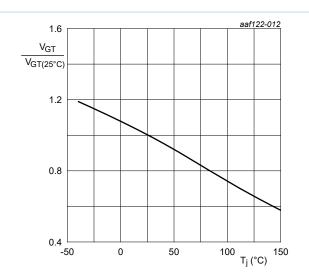


Fig. 12. Normalized gate trigger voltage as a function of junction temperature

## 10. Package outline

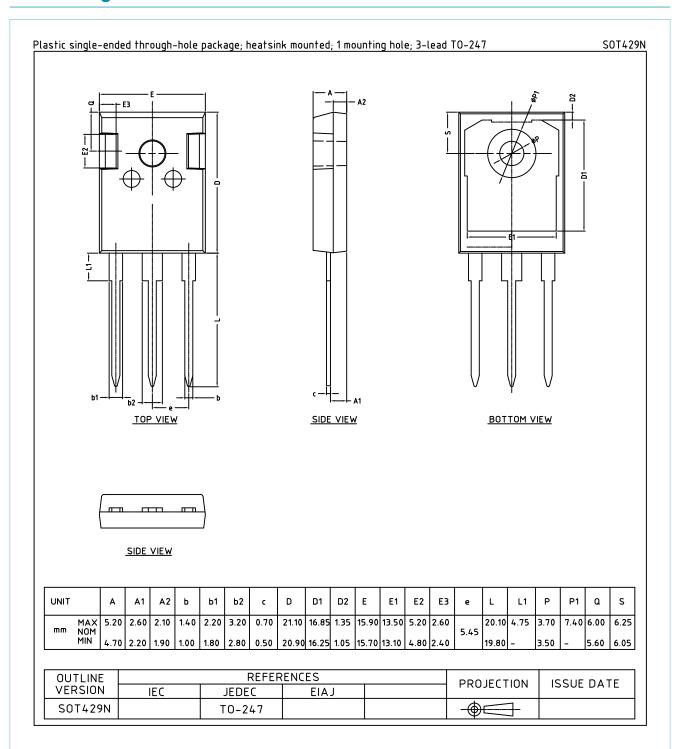


Fig. 13. Package outline TO-247 (SOT429N)

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## 11. Legal information

#### **Data sheet status**

Document status [1][2]	Product status [3]	Definition
Objective [short] data sheet	Development	This document contains data from the objective specification for product development.
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